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Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China







# Dual Self-Protected Low-Side Driver with Temperature and Current Limit

NCV8402D/AD is a dual protected Low–Side Smart Discrete device. The protection features include overcurrent, overtemperature, ESD and integrated Drain–to–Gate clamping for overvoltage protection. This device offers protection and is suitable for harsh automotive environments.

#### **Features**

- Short-Circuit Protection
- Thermal Shutdown with Automatic Restart
- Overvoltage Protection
- Integrated Clamp for Inductive Switching
- ESD Protection
- dV/dt Robustness
- Analog Drive Capability (Logic Level Input)
- NCV Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q100 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

## **Typical Applications**

- Switch a Variety of Resistive, Inductive and Capacitive Loads
- Can Replace Electromechanical Relays and Discrete Circuits
- Automotive / Industrial

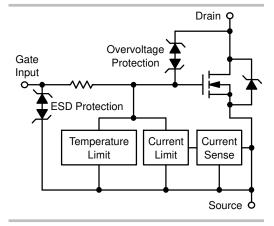


## ON Semiconductor®

#### www.onsemi.com

V <sub>(BR)DSS</sub> (Clamped)	R <sub>DS(ON)</sub> TYP	I <sub>D</sub> MAX		
42 V	165 mΩ @ 10 V	2.0 A*		

<sup>\*</sup>Max current limit value is dependent on input condition.



#### **MARKING DIAGRAM**



SO-8 CASE 751 STYLE 11



xxxxxx = V8402D or 8402AD A = Assembly Location

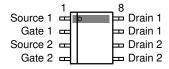
L = Wafer Lot

Y = Year

W = Work Week

= Pb-Free Package

#### **PIN ASSIGNMENT**



### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NCV8402DDR2G		2500/Tape & Reel
NCV8402ADDR2G	(Pb–Free)	

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

## **MAXIMUM RATINGS** ( $T_J = 25^{\circ}C$ unless otherwise noted)

Rating			Value	Unit
Drain-to-Source Voltage Internally Clamped		$V_{DSS}$	42	V
Drain-to-Gate Voltage Internally Clamped	$(R_G = 1.0 M\Omega)$	V <sub>DGR</sub>	42	V
Gate-to-Source Voltage		$V_{GS}$	±14	V
Continuous Drain Current		I <sub>D</sub>	Internally Limited	
Power Dissipation	@ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2)	P <sub>D</sub>	0.8 1.62	W
Maximum Continuous Drain Current	@ T <sub>A</sub> = 25°C (Note 1) @ T <sub>A</sub> = 25°C (Note 2)	I <sub>D</sub>	2.02 2.88	Α
Thermal Resistance	Junction-to-Ambient Steady State (Note 1) Junction-to-Ambient Steady State (Note 2)	$R_{ hetaJA}$ $R_{ hetaJA}$	157 77	°C/W
Single Pulse Drain–to–Source Avalanche Energy (V <sub>DD</sub> = 32 V, V <sub>G</sub> = 5.0 V, I <sub>PK</sub> = 1.0 A, L = 300 mH, $R_{G(ext)}$ = 25 $\Omega$ )		E <sub>AS</sub>	150	mJ
Load Dump Voltage (V	$_{GS}$ = 0 and 10 V, $R_{I}$ = 2.0 $\Omega$ , $R_{L}$ = 9.0 $\Omega$ , $t_{d}$ = 400 ms)	$V_{LD}$	55	V
Operating Junction and Storage Temperature		T <sub>J</sub> , T <sub>stg</sub>	-55 to 150	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. Surface—mounted onto min pad FR4 PCB, (Cu area = 40 sq. mm, 1 oz.).

2. Surface—mounted onto 1" sq. FR4 board (Cu area = 625 sq. mm, 2 oz.).

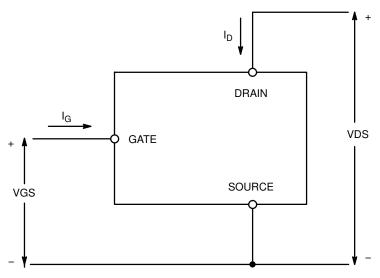


Figure 1. Voltage and Current Convention

## **ELECTRICAL CHARACTERISTICS** (T<sub>J</sub> = 25°C unless otherwise noted)

Parameter	Test Condition	Symbol	Min	Тур	Max	Unit
OFF CHARACTERISTICS		-				I
Drain-to-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>J</sub> = 25°C	V <sub>(BR)DSS</sub>	42	46	55	V
(Note 3)	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 10 mA, T <sub>J</sub> = 150°C (Note 5)	(611)600	40	45	55	
Zero Gate Voltage Drain Current	$V_{GS} = 0 \text{ V}, V_{DS} = 32 \text{ V}, T_{J} = 25^{\circ}\text{C}$	I <sub>DSS</sub>		0.25	4.0	μΑ
	V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 32 V, T <sub>J</sub> = 150°C (Note 5)			1.1	20	
Gate Input Current	$V_{DS} = 0 \text{ V}, V_{GS} = 5.0 \text{ V}$	I <sub>GSSF</sub>		50	100	μΑ
ON CHARACTERISTICS (Note 3)						-
Gate Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = 150 \mu A$	V <sub>GS(th)</sub>	1.3	1.8	2.2	V
Gate Threshold Temperature Coefficient		V <sub>GS(th)</sub> /T <sub>J</sub>		4.0	6.0	–mV/°C
Static Drain-to-Source On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$	R <sub>DS(on)</sub>		165	200	mΩ
	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 150°C (Note 5)			305	400	
	$V_{GS} = 5.0 \text{ V}, I_D = 1.7 \text{ A}, T_J = 25^{\circ}\text{C}$			195	230	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 1.7 A, T <sub>J</sub> = 150°C (Note 5)			360	460	
	$V_{GS} = 5.0 \text{ V}, I_D = 0.5 \text{ A}, T_J = 25^{\circ}\text{C}$			190	230	
	V <sub>GS</sub> = 5.0 V, I <sub>D</sub> = 0.5 A, T <sub>J</sub> = 150°C (Note 5)			350	460	
Source-Drain Forward On Voltage	V <sub>GS</sub> = 0 V, I <sub>S</sub> = 7.0 A	V <sub>SD</sub>		1.0		V
SWITCHING CHARACTERISTICS (Note 5	)					
Turn-On Delay Time (10% V <sub>IN</sub> to 90% I <sub>D</sub> )		td(on)		25	30	μS
Turn-On Rise Time (10% I <sub>D</sub> to 90% I <sub>D</sub> )		t <sub>rise</sub>		120	200	μs
Turn-Off Delay Time (90% V <sub>IN</sub> to 10% I <sub>D</sub> )	V <sub>GS</sub> = 10 V, V <sub>DD</sub> = 12 V,	td(off)		20	25	μs
Turn-Off Fall Time (90% I <sub>D</sub> to 10% I <sub>D</sub> )	$I_D = 2.5 \text{ A}, R_L = 4.7 \Omega$	t <sub>fall</sub>		50	70	μs
Slew-Rate ON (70% V <sub>DS</sub> to 50% V <sub>DD</sub> )		-dV <sub>DS</sub> /dt <sub>ON</sub>		0.8	1.2	V/μs
Slew-Rate OFF (50% V <sub>DS</sub> to 70% V <sub>DD</sub> )		dV <sub>DS</sub> /dt <sub>OFF</sub>		0.3	0.5	
SELF PROTECTION CHARACTERISTICS	G (T <sub>J</sub> = 25°C unless otherwise noted) (N	ote 4)				•
Current Limit	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 5.0 V, T <sub>J</sub> = 25°C	I <sub>LIM</sub>	3.7	4.3	5.0	Α
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 5.0 V, T <sub>J</sub> = 150°C (Note 5)		2.3	3.0	3.7	_
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 25°C		4.2	4.8	5.4	
	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, T <sub>J</sub> = 150°C (Note 5)		2.7	3.6	4.5	
Temperature Limit (Turn-off)	V <sub>GS</sub> = 5.0 V (Note 5)	T <sub>LIM(off)</sub>	150	175	200	°C
Thermal Hysteresis	V <sub>GS</sub> = 5.0 V	$\Delta T_{LIM(on)}$		15		
Temperature Limit (Turn-off)	V <sub>GS</sub> = 10 V (Note 5)	T <sub>LIM(off)</sub>	150	165	185	
Thermal Hysteresis	V <sub>GS</sub> = 10 V	$\Delta T_{LIM(on)}$		15		
GATE INPUT CHARACTERISTICS (Note 5	5)					
Device ON Gate Input Current	V <sub>GS</sub> = 5 V I <sub>D</sub> = 1.0 A	I <sub>GON</sub>		50		μΑ
	V <sub>GS</sub> = 10 V I <sub>D</sub> = 1.0 A			400		
Current Limit Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GCL</sub>		0.05		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			0.4		1
Thermal Limit Fault Gate Input Current	V <sub>GS</sub> = 5 V, V <sub>DS</sub> = 10 V	I <sub>GTL</sub>		0.15		mA
	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 10 V			0.7		1
ESD ELECTRICAL CHARACTERISTICS (		te 5)				1
Electro–Static Discharge Capability	Human Body Model (HBM)	ESD	4000			V
3	Machine Model (MM)		400			1
3. Pulse Test: Pulse Width ≤ 300 μs, Duty C	· ' '	<u> </u>		I	l	

3. Pulse Test: Pulse Width  $\leq 300~\mu s,$  Duty Cycle  $\leq 2\%.$ 

4. 5.	Fault conditions are viewed as beyond the normal operating range of the part.  Not subject to production testing.

#### **TYPICAL PERFORMANCE CURVES**

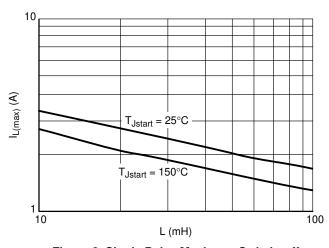


Figure 2. Single Pulse Maximum Switch-off Current vs. Load Inductance

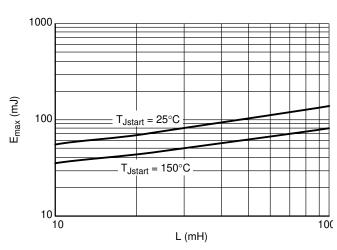


Figure 3. Single Pulse Maximum Switching Energy vs. Load Inductance

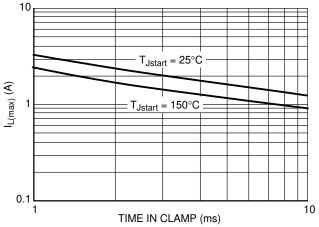


Figure 4. Single Pulse Maximum Inductive Switch-off Current vs. Time in Clamp

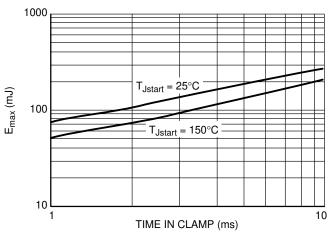


Figure 5. Single Pulse Maximum Inductive Switching Energy vs. Time in Clamp

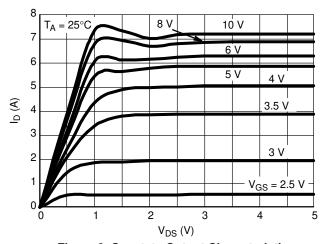


Figure 6. On-state Output Characteristics

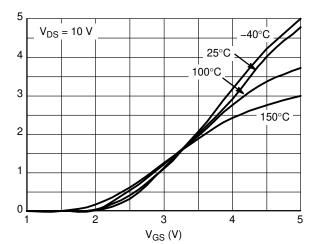


Figure 7. Transfer Characteristics

 $I_D(A)$ 

#### **TYPICAL PERFORMANCE CURVES**

ILIM (A)

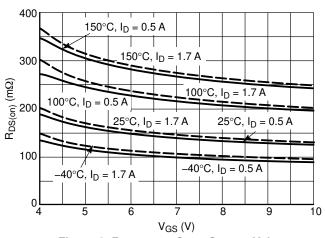


Figure 8. R<sub>DS(on)</sub> vs. Gate-Source Voltage

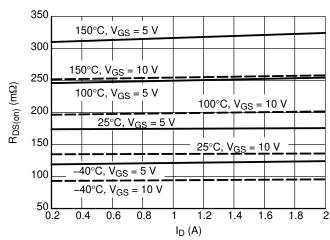


Figure 9. R<sub>DS(on)</sub> vs. Drain Current

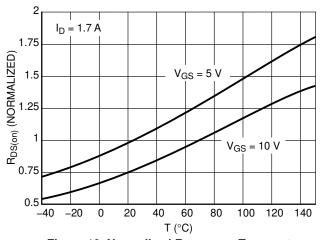


Figure 10. Normalized R<sub>DS(on)</sub> vs. Temperature

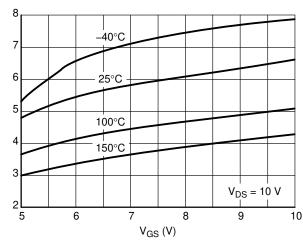


Figure 11. Current Limit vs. Gate-Source Voltage

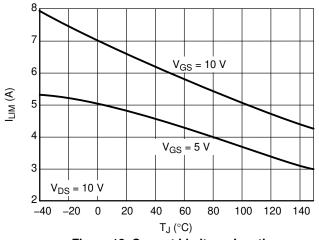


Figure 12. Current Limit vs. Junction Temperature

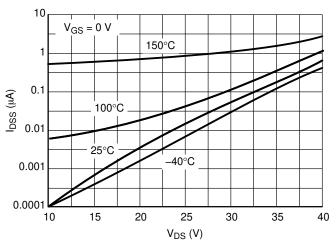


Figure 13. Drain-to-Source Leakage Current

### **TYPICAL PERFORMANCE CURVES**

DRAIN-SOURCE VOLTAGE SLOPE (V/µs)

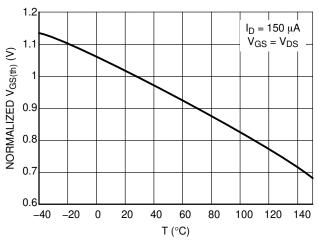


Figure 14. Normalized Threshold Voltage vs. Temperature

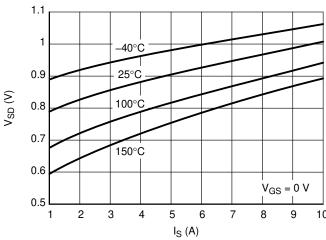


Figure 15. Source–Drain Diode Forward
Characteristics

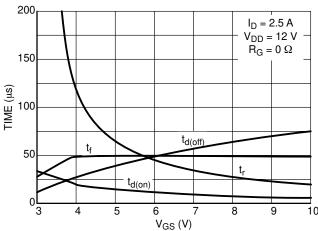


Figure 16. Resistive Load Switching Time vs.

Gate-Source Voltage

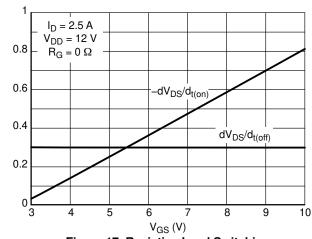


Figure 17. Resistive Load Switching
Drain-Source Voltage Slope vs. Gate-Source
Voltage

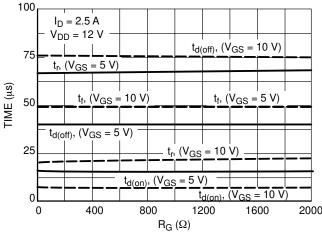


Figure 18. Resistive Load Switching Time vs.
Gate Resistance

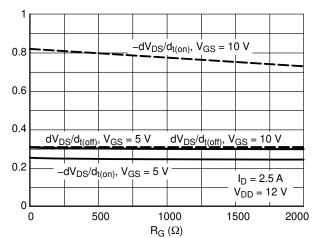


Figure 19. Drain-Source Voltage Slope during Turn On and Turn Off vs. Gate Resistance

DRAIN-SOURCE VOLTAGE SLOPE (V/μs)

## **TYPICAL PERFORMANCE CURVES**

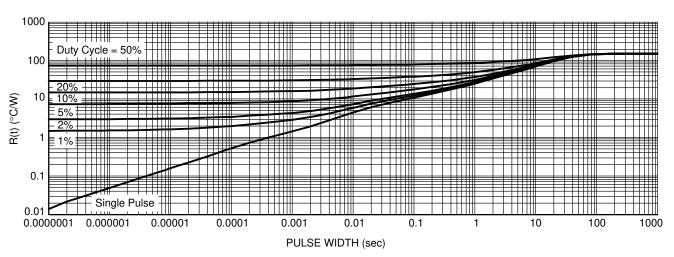


Figure 20. Transient Thermal Resistance

## **TEST CIRCUITS AND WAVEFORMS**

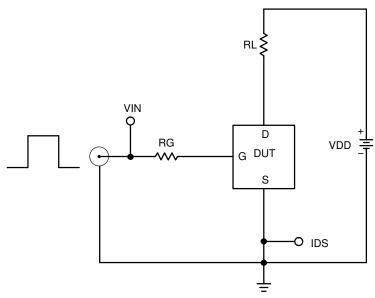


Figure 21. Resistive Load Switching Test Circuit

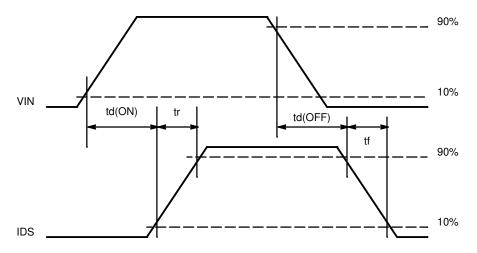


Figure 22. Resistive Load Switching Waveforms

## **TEST CIRCUITS AND WAVEFORMS**

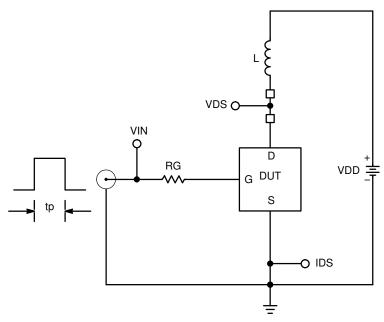


Figure 23. Inductive Load Switching Test Circuit

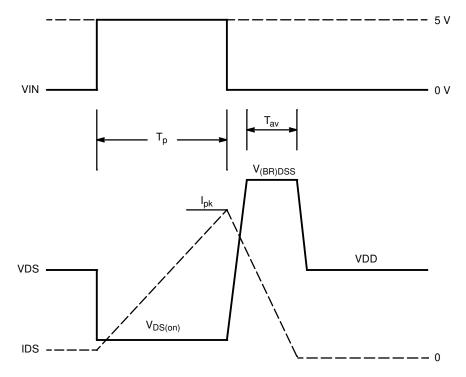
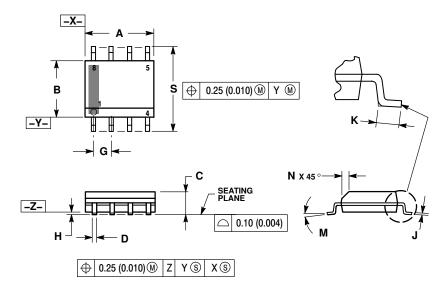


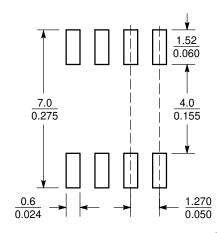
Figure 24. Inductive Load Switching Waveforms

#### PACKAGE DIMENSIONS

#### SOIC-8 CASE 751-07 **ISSUE AK**



#### SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

SCALE 6:1

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: MILLIMETER.
  DIMENSION A AND B DO NOT INCLUDE
- MOLD PROTRUSION.
  MAXIMUM MOLD PROTRUSION 0.15 (0.006)
- PER SIDE.
  DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION. 751-01 THRU 751-06 ARE OBSOLETE. NEW
- STANDARD IS 751-07.

	MILLIMETERS		INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	4.80	5.00	0.189	0.197	
В	3.80	4.00	0.150	0.157	
C	1.35	1.75	0.053	0.069	
D	0.33	0.51	0.013	0.020	
G	1.27 BSC		0.050 BSC		
Η	0.10	0.25	0.004 0.010		
J	0.19	0.25	0.007	0.010	
K	0.40	1.27	0.016	0.050	
М	0 °	8 °	0 °	8 °	
N	0.25	0.50	0.010	0.020	
S	5.80	6.20	0.228	0.244	

#### STYLE 11:

- PIN 1. SOURCE 1
  - 2. GATE 1 SOURCE 2
  - 3. GATE 2
  - DRAIN 2 DRAIN 2 5. 6.

  - DRAIN 1 DRAIN 1

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